Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/736,393	MOYER ET AL.
Examiner	Art Unit
Aimee J. Li	2183

					
	SEARCHED				
Class	Subclass	Date	Examiner		
712	238	4/29/2005	AL		
712	237	4/29/2005	AL		
712	238	7/12/2005	AL		
712	237	7/12/2005	AL		
712	238	7/25/2005	AL		
712	237	7/25/2005	AL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
712	238	7/25/2005	AL	
712	237	7/25/2005	AL	
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SEARCH (INCLUDING SEAR	NOTES CH STRATEGY	')
	DATE	EXMR
EAST	4/29/2005	AL
EAST	7/12/2005	AL
Consulted Richard Ellis	7/13/2005	AL
EAST	7/25/2005	AL
IEEE	7/25/2005	AL
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